	ES	CC	C	APP	Title: TF	RANSI	STORS, MI	CROW	AVE, SMAI	L SIG	TION APPRO			ge 1 I. No.
- (Q) -			E	xecutive M		DLR	ON TYPES	BFY40	5, BFY420	AND E		9	1	45J
Components (in	ncluding s	eries and fam	lies) si	ubmitted fo	r Extension	of Qu	alification A	pprova	1:					1
	ESCC COMPONENT VARIANTS NO.			RANG	GE OF COM	MPON	ENTS	I	BASED ON		TEST VEHICLE /	s	COMPON SIMILA	
5611/008 01 to 03								BFY4 BFY4 BFY4	20	B	FY193C(ES)	Y		
Compon Infineon Techn	ent Manuf ologies A0		2	Am Cam	peon 1-12 Neubiberg		uring Plant(s)	3	Date	of original qua : 01/06/ ficate Ref		pproval:	4
1 A2403/302000-001 - 2404				used: No ⊠	9 Yes 1 from curre		and Detail S (supply d ecifications: (Supply c	etails in		refer	ification Exten ence and date LR10, Iss. 1, 5	e i		7
Summary of pr	ocuremen	t or equivalen	t test re	esults durin	ig current v	alidity	period in su	pport of	f this applic	cation (those to ESC	C listed first)	8
Project Na	ame	Testing L	evel	_	LAT			Date coo	de	_	Quantity Delivered			
PID changes s	ince last N	loQ			9	Cur by:	rent PID V	erified			Burak Gökç	jöz		10
None [Minor* [2	ב פ						neric PID: ail PID:			SEPID-	e of Executive P000, Issue 2 000, Issue 4	d, 25.09.20	19	
Major* □	Ge im De du	ovide details i en. PID: 650V plemented et. PID: update ring ESCC E> .10.2019	Power	ed on the a	greement									
Current Manuf	acturing fa	cilities survey	ed by:		(Nam		hilo Kaupis		ative)	on			10/2018 ate)	11
Satisfactory:		Yes 🛛		No		plain						(Di		
Report Referer	nce:	IFX-AUD-20)18											

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL									
ESCC	Component title:	TRANSISTO BASED ON T	RS, MIC IYPES E	ROWAVE, SMAI FY405, BFY420	LL SIGN/ AND BF	AL, SILICON, BIPOLAR, Y450	Appl. N	No.	
	Executive Member:	DLR			Date:	10/11/2019	245	J	
								12	
Failure Analysis, DPA, NCCS ava	ailable: Yes	🗆 No	\boxtimes	(Supply data)					
Ref. No's and purposes:									
The undersigned hereby certifies on behall that the appropriate documentation has be (except as stated in box 15:) - that the repo DLR as the responsible Executive Member	en evaluated; - that ful orts and data are avail	I compliance to able at the ESC	o all ESC CC Exec	C requirements utive and therefo	is eviden re applie	s on behalf of		13	
Date: 10/11/2019						Bildale gé Burak Gökgöz			
					(S	ignature of the Executive (Coordinator)		
Continuation of Boxes above:								14	
								0.00	

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APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL							
	SCC	Component title:	TRANSISTORS, MICROWAVE, SM BASED ON TYPES BFY405, BFY42	ALL SIGNAL, SILICON, BIPOLAR,	12 18 180V		
	SLL		5,565 614 11 20 51 1403, 51 142		Appl. No.		
		Executive Member:	DLR	Date: 10/11/2019	245J		
Non compliance to	ESCC requirements:				15		
No.:	Specification		Paragraph	Non compliance			
I					16		
Executive Manage	er Disposition				17		
Application Approv		No 🗆			L		
Action / Remarks:							
					-42		
Date: 27	On. 200	7		7 ()A			
0				B. Schade, Head of ESA Prod	uct Assurance		
				and Safety Departn	nent		

					. (E)				
			APPLICATION FOR	EXTENSION O	F ESCC QU	ALIFICATION	N APPR	OVAL	Page 4
and a	ESCC	Co		ISTORS, MICRO ON TYPES BEY				ON, BIPOLAR,	Appl. No.
	R. M.	Ex	ecutive Member: DLR			D	ate:	10/11/2019	245J
NNEX 1: L	IST OF TESTS DONE TO	SUPPO	RT EXTENSION OF QUAL	IFICATION					
ests condu	ucted in compliance with:								
-	ESCC 5010 generic spec	ification; (Chart F4 (for ESCC/QPL p	parts);					
ests vehic	le identification/description	n:							
1922LR1	0 BFY193C(ES	5)							
				50)					
etail Spe	cification reference: ES	SCC 561	1/006 Issue 7, Nov. 201	6					
Chart		Tick	St. H. State	Date Code	Tested	No. of	C	omments if not	performed.
F4A	Test	when done	Conditions	Diffusion Lot	Qty	Rejects	Comments on Rejection		
Environmental/Mechanical Subgroups	Thermal Shock Test		ESCC 5010 Para.	1848A	8	0			
			9.5.2		•	•			
	Shock Test		MIL-STD-750 Test Method 2016					n.a. acc. De	tail Spec
	Vibration Test		MIL-STD-750 Test					n.a. acc. De	tail Spec
ubgu	Constant	8443	Method 2056 MIL-STD-750 Test						
al S	Acceleration		Method 2006					n.a. acc. De	tail Spec
Janic	Seal Test		MIL-STD-750 Test Method 1071					n.a. acc. De	tail Spec
Mech	Moisture	57	MIL-STD-750 Test	10404	0	0			
Ital/I	Resistance		Method 1021	1848A	8	0			
imer	Seal Test	\boxtimes	MIL-STD-750 Test Method 1071	1848A	8	0			
viror	Electrical		Table 2 of the Detail			8 0			
Ë	Measurements at Room Temp.	\boxtimes	Specification	1848A	8				
2 2): 	ESCC Basic		8	0			
	External Visual Inspection		Specification No. 20500	1848A					
			MIL-STD-750 Test		_				
	Operating Life		Method 1026				Forme	er data from W	ater available
Endurance Subgroup*	Electrical Measurements			Detail			Form	er data from W	afer available
ndura	during Endur. Test		Specification						
щŊ	External Visual	-	ESCC Basic				F		ofor our list.
	Inspection		Specification No. 20500				Forme	er data from W	aler available

* LAT2 on actual wafer was performed satisfactorily used in:

Assembly Lot: 1008.02 0715.02 Date Code: 1016A 0716B

Chart F4B	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
o – ents	Electrical Measurements at Room Temp.		Table 2 of the Detail Specification				
Subgrou easurem	Electrical Measurements at High & Low Temp's		Table 3 of the Detail Specification				
Electrical Subgroup – Electrical Measurements	External Visual Inspection		ESCC Basic Specification No. 20500				
	Special Testing		The Detail Specification				n.a. acc. Detail Spec
Electrical Subgroup – Assembly Capability Tests	Solderability Test		MIL-STD-750 Test Method 2026	1848A	4	0	
	Permanence of Marking		ESCC Basic Specification No. 24800				n.a. due to laser marking
Electr Cap	Terminal Strength		MIL-STD-750 Test Method 2036	1848A	4	0	
De- encapsulation Tests	Internal visual inspection	⊠	ESCC Basic Specification No. 20400	1848A	6	0	
	Bond Strength	⊠	MIL-STD-750 Test Method 2037	1848A	6	0	
	Die Shear	⊠	MIL-STD-750 Test Method 2017	1848A	6	0	

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EC				E ECOO OILLI IPIO	TION ADDDOV/AL	23 20			
						Page 7			
ES		nponent title:	TRANSISTORS, MICH BIPOLAR, BASED ON			Appl. No.			
	Exe	cutive Member:	DLR	Date :	e 10/11/2019	245J			
NOTES	S ON THE COMPLETIO	N OF THE APPL	ICATION FORM FOR I	ESCC QUALIFICATIO	ON EXTENSION APPROVA	L			
ENTRIES Form heading	shall indicate: - the title Member; - the entering				aname of the series, family	; - the Executive			
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.								
Box 2; 3 and 4	As per QPL entry; other	wise, an explana	ation of the changes mu	st be supplied.					
Box 5					d revision letter, current at t date of the application, see E				
Box 6		e listed in Box 1	5. In case the reference	ed specification in B	n particular deviations from t lox 5 have currently a diffe ents.				
Box 7	Must reference the repo	ort(s) supplied in	support of the application	on.					
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.								
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.								
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.								
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.								
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.								
Box 13	Enter only the name of Coordinator.	f the Executive I	Member (i.e., CNES, D	LR, ESTEC, etc.) an	d the signature of the respo	onsible Executive			
Box 14	To be used when there the relevant Box. Box 1				ntify box affected and refere e expanded.	nce the Box 14 in			
Box 15	Fill in Table as requeste	ed.							
Box 16	Any additional action de by the ESCC Executive				nitted data to a standard like npliance.	ly to be accepted			
Box 17					s or restrictions, modificatio by the representative for Es				
Box 18	Fill in Table as requeste	ed.							
Box 19	Confidential Details of F	PID changes incl	uding those of a confide	ntial nature, shall be	provided.				
Box 20	State noncompliance w shall be sequentially nu			ragraph(s). To simplit	fy reference in Box 16 each	nonconformance			
Box 21	Any additional action de by the ESCC Executive				nitted data to a standard like npliance.	ly to be accepted			
Box 22	Additional Comments.								